74F38 Quad Two-Input NAND Buffer (Open Collector)

FAIRCHILD

SEMICONDUCTOR

74F38 Quad Two-Input NAND Buffer (Open Collector)

General Description

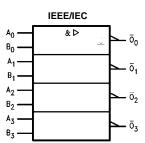
This device contains four independent gates, each of which performs the logic NAND function. The open-collector outputs require external pull-up resistors for proper logical operation.

Ordering Code:

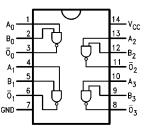
Order Number	Package Number	Package Description
74F38SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F38SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F38PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Unit Loading/Fan Out

Pin Names	Description	U.L. HIGH/LOW	Input I _{IH} /I _{IL} Output I _{OH} /I _{OL}		
A _n , B _n	Inputs	1.0/2.0	20 µA/-1.2 mA		
\overline{O}_n	Outputs	OC (Note 1) /106.6	OC (Note 1) /64 mA		

Note 1: OC = Open Collector

Function Table

Inputs		Output		
Α	в	о		
L	L	Н		
L	н	н		
н	L	Н		
н	н	L		

H = HIGH Voltage Level L = LOW Voltage Level 74F38

Absolute Maximum Ratings(Note 2)

$-65^{\circ}C$ to $+150^{\circ}C$
$-55^{\circ}C$ to $+125^{\circ}C$
$-55^{\circ}C$ to $+150^{\circ}C$
-0.5V to +7.0V
-0.5V to +7.0V
-30 mA to +5.0 mA
$-0.5 V$ to $V_{\mbox{\scriptsize CC}}$
-0.5V to +5.5V
twice the rated $I_{OL} \left(\text{mA} \right)$

Recommended Operating Conditions

Free Air Ambient Temperature	
Supply Voltage	

 $0^{\circ}C$ to $+70^{\circ}C$ +4.5V to +5.5V

Note 2: Absolute maximum ratings are values beyond which the device -0.5V to V_{CC} may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

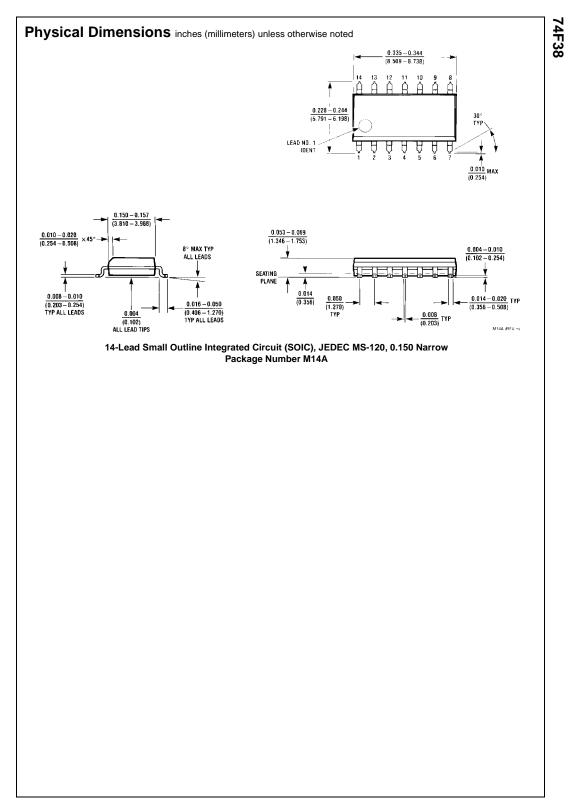
Note 3: Either voltage limit or current limit is sufficient to protect inputs.

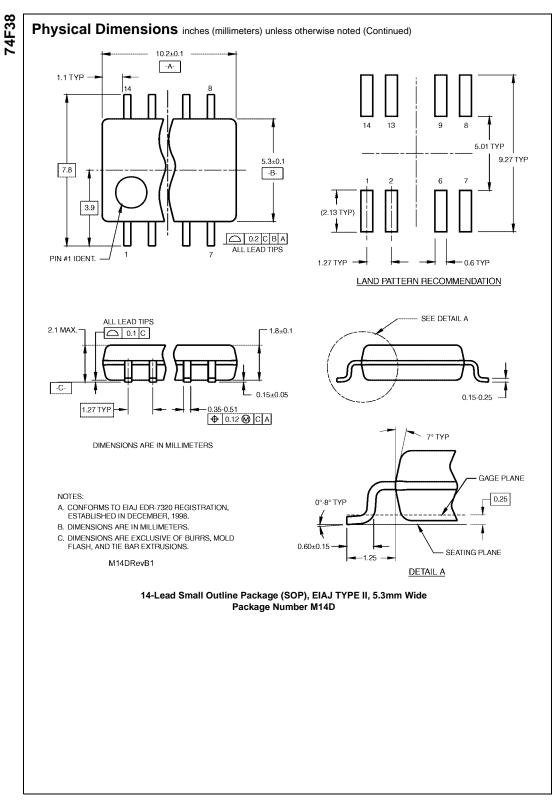
DC Electrical Characteristics

Symbol	Parameter	Min	Тур	Max	Units	V _{cc}	Conditions	
VIH	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal	
VIL	Input LOW Voltage			0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = -18 mA	
V _{OL}	Output LOW 10% V _{CC} Voltage			0.55	V	Min	I _{OL} = 64 mA	
IIH	Input HIGH Current			5.0	μA	Max	V _{IN} = 2.7V	
I _{BVI}	Input HIGH Current Breakdown Test			7.0	μΑ	Max	V _{IN} = 7.0V	
V _{ID}	Input Leakage Test	4.75			v	0.0	I _{ID} = 1.9 μA All Other Pins Grounded	
I _{OD}	Output Leakage Circuit Current			3.75	μΑ	0.0	V _{IOD} = 150 mV All Other Pins Grounded	
IIL	Input LOW Current			-1.2	mA	Max	$V_{IN} = 0.5V$	
I _{OHC}	Open Collector, Output OFF Leakage Test			250	μΑ	Min	V _{OUT} = V _{CC}	
I _{CCH}	Power Supply Current		2.1	7.0	mA	Max	V _O = HIGH	
I _{CCL}	Power Supply Current		26.0	30.0	mA	Max	V _O = LOW	

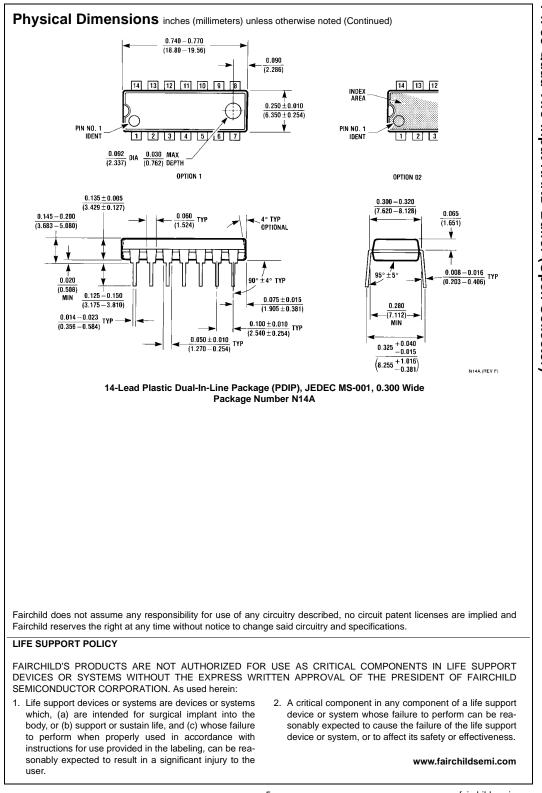
AC Electrical Characteristics

		$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		Units
Symbol	Parameter						
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	6.5	9.7	12.5	6.5	13.0	ns
t _{PHL}	$A_n, B_n \text{ to } \overline{O}_n$	1.5	2.1	5.0	1.5	5.5	115





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5